

-30V P-Channel Enhancement Mode MOSFET

Description

The AP3401CI uses advanced Trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 2.5V. This device is suitable for use as a Battery protection or in other Switching application.

General Features

$V_{DS} = -30V$ $I_D = -4.0A$

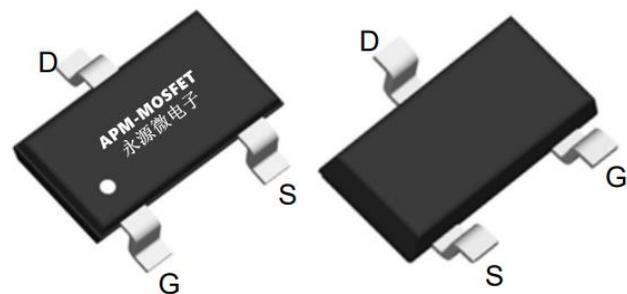
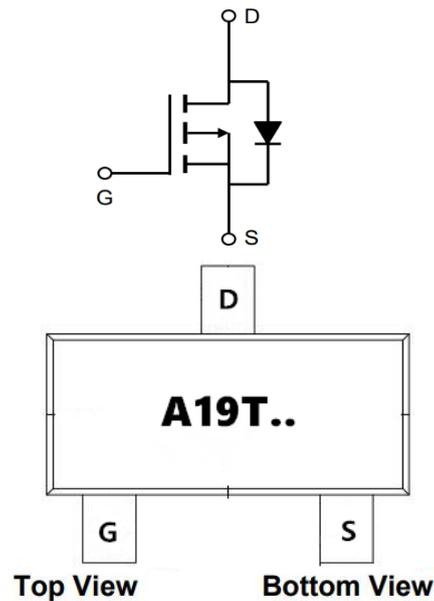
$R_{DS(ON)} < 68m\Omega @ V_{GS}=4.5V$ (Type: **58mΩ**)

Application

Battery protection

Load switch

Uninterruptible power supply



Package Marking and Ordering Information

Product ID	Pack	Marking	Qty(PCS)
AP3401CI	SOT23L	A19T..	3000

Absolute Maximum Ratings ($T_C=25^\circ C$ unless otherwise noted)

Symbol	Parameter	Max.	Units
V_{DS}	Drain-Source Voltage	-30	V
V_{GS}	Gate-Source Voltage	± 12	V
$I_D @ T_C=25^\circ C$	Continuous Drain Current, $V_{GS} @ -10V^1$	-4.0	A
$I_D @ T_C=100^\circ C$	Continuous Drain Current, $V_{GS} @ -10V^1$	-2.3	A
IDM	Pulsed Drain Current ^{note1}	-14	A
P_D	Power Dissipation $T_A = 25^\circ C$	1.1	W
$R_{\theta JA}$	Thermal Resistance Junction-Ambient ¹	125	$^\circ C/W$
$R_{\theta JC}$	Thermal Resistance Junction-Case ¹	150	$^\circ C/W$
TJ, TSTG	Operating and Storage Temperature Range	-55 to +150	$^\circ C$

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Electrical Characteristics (T_J=25°C, unless otherwise noted)

Symbol	Parameter	Test Condition	Min	Typ	Max.	Units
V(BR)DSS	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D = -250μA	-30	-33	-	V
IDSS	Zero Gate Voltage Drain Current	V _{DS} = -30V, V _{GS} =0V,	-	-	-1	μA
IGSS	Gate to Body Leakage Current	V _{DS} =0V, V _{GS} = ±12V	-	-	±100	nA
VGS(th)	Gate Threshold Voltage	V _{DS} = V _{GS} , I _D = -250μA	-0.5	-0.9	-1.5	V
RDS(on)	Static Drain-Source on-Resistance note2	V _{GS} = -4.5V, I _D = -3A	-	58	68	mΩ
		V _{GS} = -2.5V, I _D = -1A	-	71	96	mΩ
Ciss	Input Capacitance	V _{DS} = -15V, V _{GS} =0V, f=1.0MHz	-	553	-	pF
Coss	Output Capacitance		-	57	-	pF
Crss	Reverse Transfer Capacitance		-	35	-	pF
Q _g	Total Gate Charge	V _{DS} = -15V, I _D = -3A, V _{GS} = -10V	-	6.5	-	nC
Q _{gs}	Gate-Source Charge		-	1.4	-	nC
Q _{gd}	Gate-Drain("Miller") Charge		-	1.7	-	nC
td(on)	Turn-on Delay Time	V _{DD} =-15V, I _D =-3A, V _{GS} =-10V, R _{GEN} =2.5Ω	-	10	-	ns
t _r	Turn-on Rise Time		-	86	-	ns
td(off)	Turn-off Delay Time		-	150	-	ns
t _f	Turn-off Fall Time		-	357	-	ns
IS	Maximum Continuous Drain to Source Diode Forward Current		-	-	-4.2	A
ISM	Maximum Pulsed Drain to Source Diode Forward Current		-	-	-16.8	A
VSD	Drain to Source Diode Forward Voltage	V _{GS} =0V, I _S = -4.2A	-	-0.8	-1.2	V

Note :

- 1、 The data tested by surface mounted on a 1 inch 2 FR-4 board with 2OZ copper.
- 2、 The data tested by pulsed , pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$
- 3、 The power dissipation is limited by 150°C junction temperature
- 4、 The data is theoretically the same as ID and IDM , in real applications , should be limited by total power dissipation.

Typical Characteristics

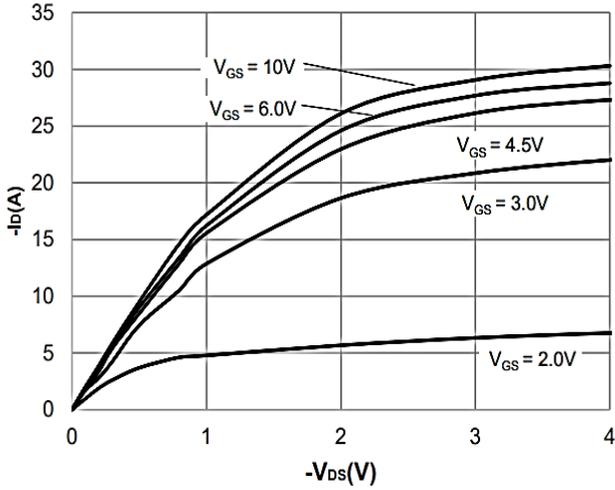


Figure1: Output Characteristics

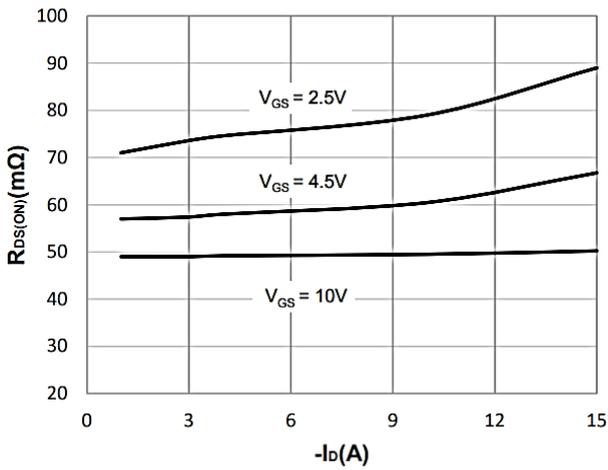


Figure 3: On-resistance vs. Drain Current

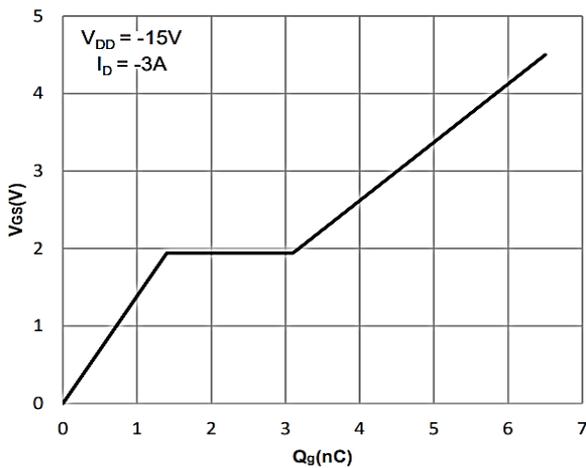


Figure 5: Gate Charge Characteristics

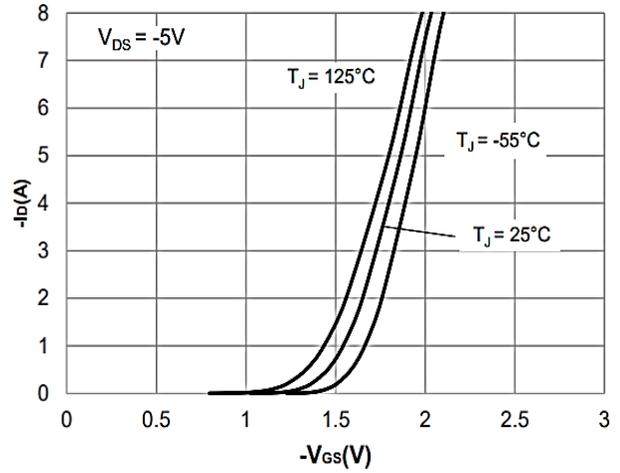


Figure 2: Typical Transfer Characteristics

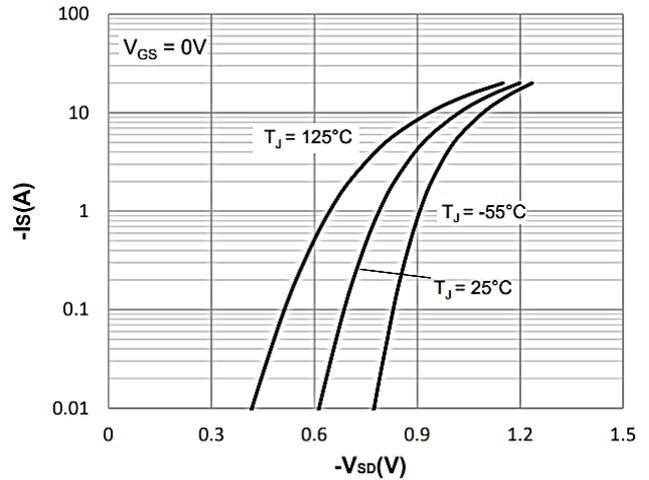


Figure 4: Body Diode Characteristics

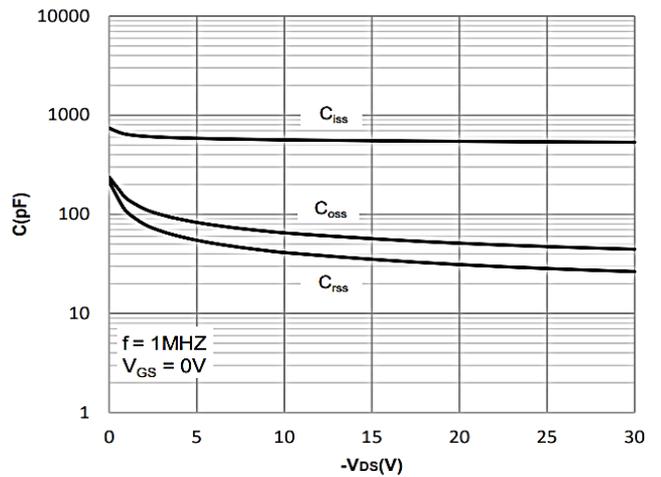


Figure 6: Capacitance Characteristics



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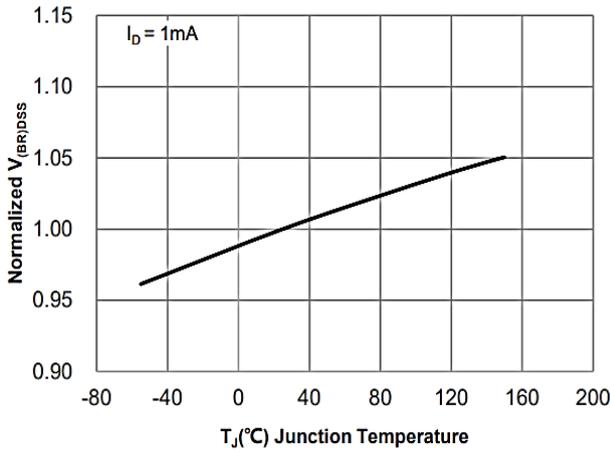


Figure 7: Normalized Breakdown Voltage vs. Junction Temperature

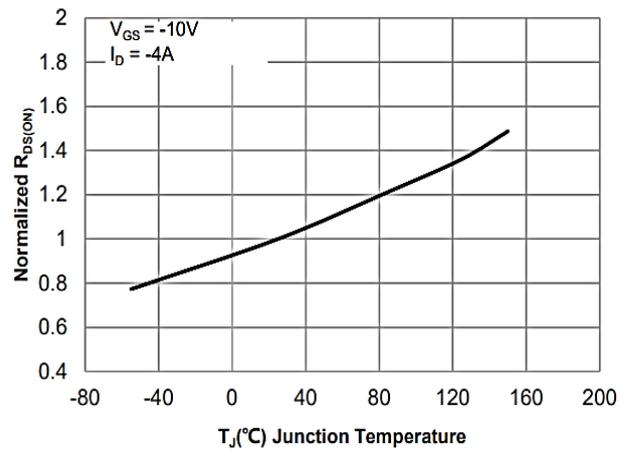


Figure 8: Normalized on Resistance vs. Junction Temperature

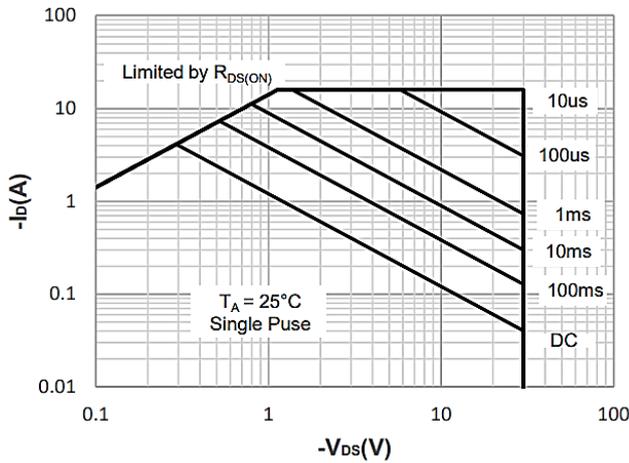


Figure 9: Maximum Safe Operating Area

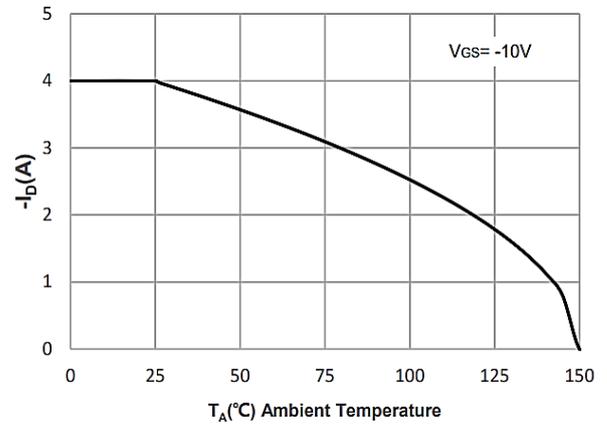


Figure 10: Maximum Continuous Drain Current vs. Ambient Temperature

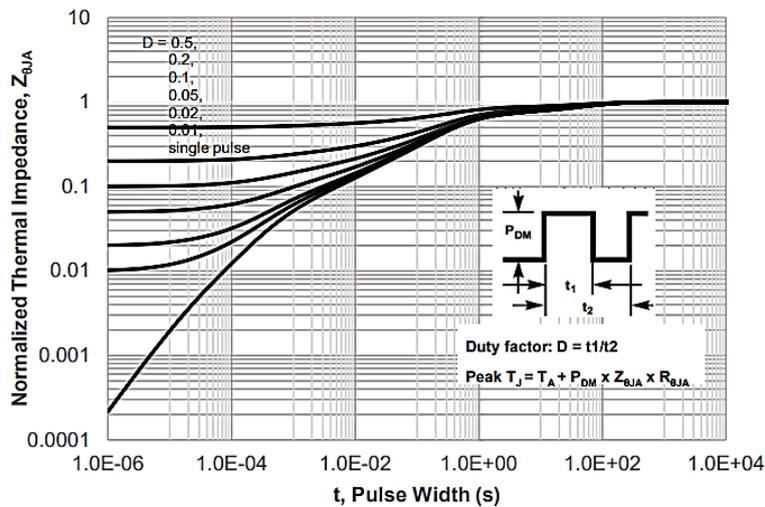
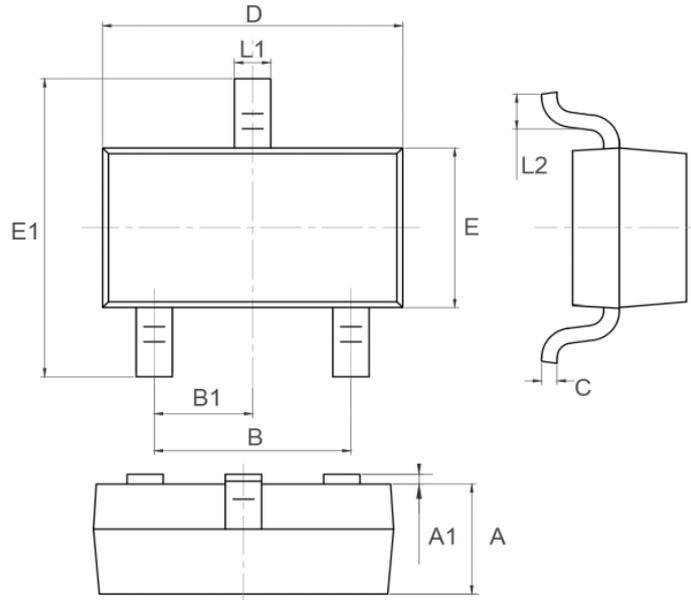


Figure.11: Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

Package Mechanical Data-SOT23L



Symbol	Dim in mm		
	Min.	Typ.	Max.
A	0.9	1	1.15
A1	0	0.05	0.1
B	1.8	1.9	2
B1	0.95TYP		
C	0.08	0.115	0.15
D	2.8	2.9	3
E	1.2	1.3	1.4
E1	2.25	2.4	2.55
L1	0.3	0.4	0.5
L2	0.2	0.35	0.5

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Edition	Date	Change
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